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	3 Are soft breakdown and hard breakdown of ultrathin gate oxid different failure mechanisms? Sune, J.; Mura, G.; Miranda, E.; Electron Device Letters, IEEE, Volume: 21, Issue: 4, April 2000 Pages:167 - 169 [Abstract] [PDF Full-Text (56 KB)] IEEE JNL 4 Undercut ridge structures: a novel approach to 1.3/1.55 µm vocavity lasers designed for continuous-wave operation Salet, P.; Plais, A.; Derouin, E.; Fortin, C.; Starck, C.; Jacquet, J.; Brillo	ertica			

5 Design and performance of the DZero data acquisition system
Briskin, G.; Clements, M.; Cutts, D.; Kakaz, K.; Mattingly, S.; Watts, G.; Zelle

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